Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,987	TEI ET AL.	
Examiner	Art Unit	
Helen L. Pezzuto	1713	

SEARCHED				
Class	Subclass	Date	Examiner	
526	333			
	336	3/17/2006	HP	
Above	updated	9/8/2006	HP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
STIC STN search	2/15/2006	НР
West, Inventors search	3/17/2006	НР
West, inventors search updated	9/8/2006	НР